

## IGBT<sup>3</sup> Chip

#### **FEATURES:**

- 600V Trench & Field Stop technology
- low V<sub>CE(sat)</sub>
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling

#### This chip is used for:

• power module



Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC100T60R3	600V	200A	9.73 x 10.23 mm <sup>2</sup>	sawn on foil	Q67050- A4345-A101

#### **MECHANICAL PARAMETER:**

WECHANICAL PARAMETER:					
Raster size	9.73 x 10.23				
Emitter pad size	( 4.256 x 1.938 ) x 4 ( 4.256 x 2.356 ) x 4				
Gate pad size	1.615 x 0.817				
Area total / active	99.5 / 80.1				
Thickness	70	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max. possible chips per wafer	121 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm AlSiCu				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond AI, <500μm					
Reject ink dot size	Ø 0.65mm ; max 1.2mm				
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit		
Collector-emitter voltage, T <sub>j</sub> = 25 °C	V <sub>CE</sub>	600	V		
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)			
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub> 600		Α		
Gate emitter voltage	$V_{GE}$	±20	V		
Operating junction and storage temperature	$T_{\rm j}, T_{\rm stg}$	-40 +175	°C		
SC data, $V_{GE} = 15V$ , $V_{CC} = 360V$	Tvj = 150°C	to	6	μs	
	Tvj = 25°C	tp	8		

<sup>1)</sup> depending on thermal properties of assembly

### STATIC CHARACTERISTICS (tested on chip), $T_{j}$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value		
i arameter		Conditions	min.	typ.	max.	Unit
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ = 4 $mA$	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =200A	1.05	1.45	1.85	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C$ =3200 $\mu$ A , $V_{GE}$ = $V_{CE}$	5.0	5.8	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{CE}$ =600V , $V_{GE}$ =0V			10.1	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V				nA
Integrated gate resistor	$R_{Gint}$			2		Ω

#### **ELECTRICAL CHARACTERISTICS** (verified by design/characterization):

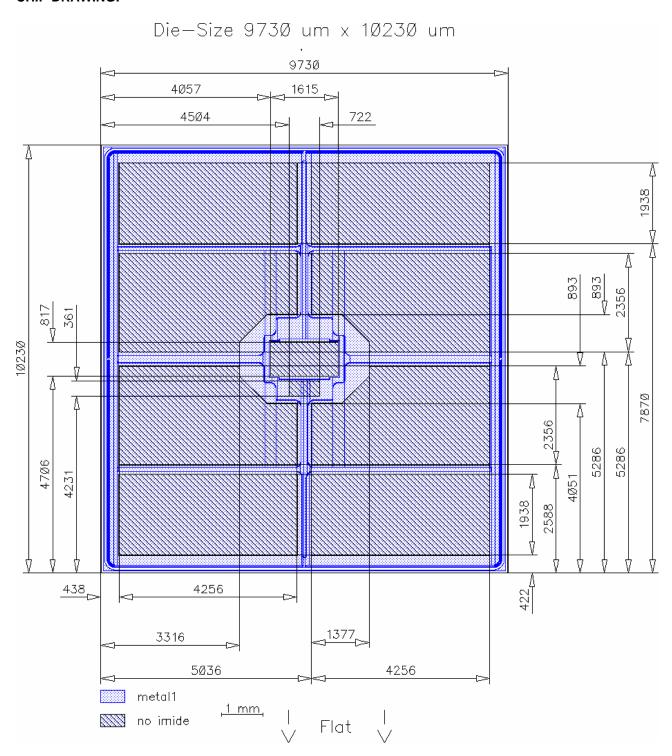
Parameter	Symbol	Conditions	Value			Unit
raiametei		Conditions	min.	typ.	max.	Ollit
Input capacitance	Ciss	V <sub>CE</sub> =25V,		12335		pF
Output capacitance	Coss	$V_{GE}=0V$ ,		769		
Reverse transfer capacitance	C <sub>rss</sub>	f=1MHz		366		

#### SWITCHING CHARACTERISTICS (verified by design/characterization), inductive load

Parameter	Symbol	Conditions	Value 2)			Unit
raiametei			min.	typ.	max.	Onne
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =125°C		145		ns
Rise time	$t_{\rm r}$	$V_{\rm CC} = 300  \text{V},$		30		
Turn-off delay time	$t_{d(off)}$	V <sub>CC</sub> =300V, I <sub>C</sub> =200A, V <sub>GE</sub> =-15/15V,		340		
Fall time	$t_{f}$	$R_{\rm G}$ = $2\Omega$		60		

 $<sup>^{2)}</sup>$  values also influenced by parasitic L- and C- in measurement and package.

#### **CHIP DRAWING:**





# This chip data sheet refers to the device data sheet DESCRIPTION: AQL 0,65 for visual inspection according to failure catalog Electrostatic Discharge Sensitive Device according to MIL-STD 883 Test-Normen Villach/Prüffeld

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